

### MICRO SIM CONNECTOR, HINGE TYPE, 1.60MM MAX HEIGHT

#### 1.0 SCOPE

This Product Specification covers the performance requirements of the SIM Card Connector (Hinge Type).

#### 2.0 PRODUCT DESCRIPTION

#### 2.1 PRODUCT NAME AND SERIES NUMBER(S)

#### **Product Name**

Series Number

MICRO SIM CONNECTOR, HINGE TYPE, 1.60MM MAX HEIGHT 78800

#### 2.2 DIMENSIONS, MATERIALS, PLATINGS AND MARKINGS

See Sales Drawing for information on dimensions, materials, platings and markings.



#### TENTATIVE RELEASE:

THIS SPECIFICATION IS BASED ON DESIGN OBJECTIVES AND IS STRICTLY TENTATIVE. PRELIMINARY TEST DATA MAY EXIST, BUT THIS SPECIFICATION IS SUBJECTED TO CHANGE BASED ON THE RESULTS OF ADDITIONAL TESTING AND EVALUATION.

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#### 3.0 APPLICABLE DOCUMENTS AND SPECIFICATIONS

The following documents form a part of this specification to the extended specified herewith. In the event of conflict between the requirements of this specification and the product drawing, the product drawing shall take precedence.

#### 4.0 RATINGS

### 4.1 CURRENT RATING

0.5Amps Max. per contact

#### 4.2 VOLTAGE RATING 5 Volt DC Max.

4.3 TEMPERATURE

Operating:

- 30°C to + 85°C

#### 5.0 MECHANICAL INTERFACE

#### 5.1 CARD INTERFACE

SIM card interface: GSM 11.11 specification

#### **5.2 PWB INTERFACE**

Plating on PWB pads: OSP plated copper

#### 6.0 PERFORMANCE

#### **6.1 ELECTRICAL REQUIREMENTS**

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
1	Contacts Low Level Contact Resistance (LLCR)	Mate connectors with dry circuit ( <b>20</b> mV, <b>100</b> mA MAX) on mated connector. Refer to appendix 1. (IEC 60512-2-1)	<b>100 mΩ</b> [MAXIMUM] Value includes bulk resistance of terminal
2	Insulation Resistance	Unmated connectors: apply a voltage of <b>500</b> VDC between adjacent contact for 1 minutes (IEC 60512-3-1)	<b>1000 ΜΩ</b> [MINIMUM]

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3	Dielectric Withstanding Voltage	Unmated connectors: apply a voltage of <b>500</b> VAC between adjacent contact for <b>1</b> minutes (IEC 60512-3-1)	No voltage breakdown
4	Temperature Rise	Mated and measure the temperature rise of contact, when rated current is passed. (IEC 60512-5-1)	Temperature Rise <b>+30°C</b> [MAXIMUM]

#### 6.2 MECHANICAL REQUIREMENTS

ITEM	DESCRIPTION	TEST CONDITION	REQUIREMENT
5	Contact Normal Force	Apply perpendicular force to terminal at the rate of 12.5mm/min. Measure contact normal force at <b>0.32mm</b> working height, read at return curve. Refer to appendix 2.	0.20 N [MINIMUM] 1.30 N REF. [MAXIMUM]
6	Lock/unlock force	Lock and unlock shell from housing at a rate of 25mm/min. Lock and unlock 3 times before taking initial reading.	Unlocking/Locking force 15N (WITH CARD)
7	Durability (Terminal)	Mate and unmate connector at vertical direction to maximum deflection case for • 5000cycles • At a rate of 500~600cycles/hour Take LLCR and normal force readings at 5000 <sup>th</sup> cycles. Refer to appendix 1 and 2. (EIA-364-09)	Contact Normal Force <b>0.20N</b> [MINIMUM] LLCR <b>100 mΩ.</b> [MAXIMUM]

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8	Durability (Locking system)	Mate and unmate connector to 500cycles. Take reading at 500 <sup>th</sup> cycles. 1cycle (card loaded) = shell closed $\rightarrow$ shell locked $\rightarrow$ shell unlocked $\rightarrow$ shell opened.	Unlocking/locking force <b>1.0 N (With Card)</b> [MINIMUM] Contacts contact resistance <b>100 mΩ</b> [MAXIMUM] No mechanical damage
9	Vibration (Random)	Frequency: 10~100 Hz, 0.0132 g <sup>2</sup> /Hz; Frequency: 100~500Hz, -3dB/Oct Applied for 1 hour in each 3 mutually perpendicular axes (IEC60068-2-64 Fh)	Contact resistance <b>100 mΩ</b> [MAXIMUM] Discontinuity < 1 μs
10	Mechanical Shock (specified pulse)	Pulse shape = half sine Peak acceleration = 490m/s2 (50G) Duration of pulse = 11ms Apply 3 successive shocks in each direction along the 3 mutually perpendicular axes. (IEC-60068-2-27 EA)	Contact resistance <b>100 mΩ</b> [MAXIMUM] Meet Contact Force Spec Discontinuity < 1 μs

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ITEM	DESCRIPTION	TEST CONDITION		R	EQUIREME	NT	
11	High Temperature Storage Life	At +85°C for 96 hours Recovery: 2 hours at ambie (IEC60068-2-2 Bb)	nt atmosphere	Contact No me corrosi	s contact res <b>100 mΩ</b> [MAXIMUM] echanical da on and oxida contact area	sistance ] Image, ation at	
12	Thermal Shock	25 cycle at Ta = -55°C for 0 change of temp = 25°C MA $T_b$ = +85°C for 0.5hour, the ambient Recovery: 2hours at ambien (IEC60068-2-14 Na)	1.5 hours, then X 5min, then, n cool to nt atmosphere	Contacts contact resistant <b>100 mΩ</b> [MAXIMUM] No mechanical damage corrosion and oxidation a contact area			
13	Damp Heat (Cyclic)	Temp 25-55°C and 90-1009 cycles of 24hours. Recovery at 25°C and 25~7 2hours. (Typical cycle in temp 25°C hours; then maintain at 55°0 (IEC60068-2-30Db)	%RH for 18 75%RH for → 55°C in 3 C for 9hours)	Contact Insu No vo No me corrosi	Contacts contact resistance <b>100 mΩ</b> [MAXIMUM] Insulation resistance <b>1000 MΩ</b> [MINIMUM] No voltage breakdown No mechanical damage, corrosion and oxidation at contact area		
14	Solderability	Solder paste is deposited o plate via stencil. The connectors are steam a placed onto the solder past The substrate is processed forced hot convection oven. section 9.0 for temp profile. The connectors are remove ceramic and inspected. Steam Aging: 8 hour (ANSI-J-STD 002)	Solde	r coverage = [MINIMUM]	= 95%		
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15	15 Resistance to Soldering Condition	Unmated sample to be passed through reflow over according to temperature profiles shown in section 9.0	No mechanical damage
		Reflow cycle: 3X times	

#### 7.0 PACKAGING

Parts shall be packaged to protect against damage during handling, transit and storage. The parts shall be carried in reels inside boxes. For details, kindly refer to Packaging Specification PK-78800-001 and Sale drawing SD-78800-001.

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#### 8.0 TEST SEQUENCES

	Full Qualification Test				Screen Test					
Test Group →	Group	Group	Group	Group	Group	Group	Group	Gro	up 8	Group
	1	2	3	4	5	6	7	А	В	9
Test or Examination $\Psi$										
Sample size	5	5	5	5	5	5	5	5	5	5
Resistance to Soldering Conditions	1	1	1	1	1	1	1	1	1	
Contact Resistance (LLCR)	2,4,6			2,4,6	2,4	2,4	2,6	2,5		
Insulation Resistance		2,5							2	
Dielectric Withstanding Voltage		3,6							3	
Temperature Rise			2							
Contact Normal Force								3,6		
Durability (Terminal)	3							4		
Durability (Locking system)							4			
Lock/unlock force							3,5			
Vibration (Random)				3						
Mechanical Shock				5						
High Temperature Storage Life					3					
Thermal Shock						3				
Damp Heat	5	4								
Solderability										1

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Description	Requirement		
Average Ramp Rate	3°C/sec Max		
Preheat Temperature	150°C Min to 180°C Max		
Preheat Time	120 to 180 sec		
Ramp to Peak	3°C/sec Max		
Time over Liquidus (217°C)	65 to 150 sec Max		
Peak Temperature	255 -0/+5°C		
Time within 5°C of Peak	10 sec		
Ramp - Cool Down	5°C/sec Max		
Time 40°C to 220	3 to 8 Min		

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